Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/810,895	TANAKA ET AL.
Examiner	Art Unit

2861

Huan H. Tran

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	search_see ory printout	2/10/2006	ННТ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search (USPAT;US_PGPUB;JPO;EPO;DER WENT;IBM_TDB)-see search history printout	2/10/2006	ннт	